

Notice of References Cited	Application/Control No. 09/942,887	Applicant(s)/Patent Under Reexamination CALLAHAN ET AL.	
	Examiner Helen L. Pezzuto	Art Unit 1713	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-4,434,215	02-1984	Wszolek et al.	429/144
	B	US-4,505,797	03-1985	Hodgdon et al.	204/252
	C	US-5,858,264	01-1999	Ichino et al.	252/62.2
	D	US-2001/0030127 A1	10-2001	Li et al.	204/252
	E	US-2002/0155327 A1	10-2002	Faris	429/9
	F	US-2003/0022047 A1	01-2003	Chen et al.	429/29
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

Notice of References Cited

Application/Control No.

09/942,887

Applicant(s)/Patent Under
Reexamination
CALLAHAN ET AL.

Examiner

Helen L. Pezzuto

Art Unit

1713

Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-5,226,902	07-1993	Bae et al.	604/892.1
	B	US-6,258,870	07-2001	Hubbell et al.	522/26
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.